

Title of Cha	ange:	Micro8 Assembly and Test Site Transfer.			
Proposed	first ship date:	26 September 2018			
Contact in	formation:	Contact your local ON Semiconductor Sales Office or < <u>logic.fpcn22188x@onsemi.com</u> >			
Samples:		Contact your local ON Semiconductor Sales Office or < <u>PCN.samples@onsemi.com</u> > Sample requests are to be submitted no later than 30 days from the date of first notification, Initial PCN or Final PCN, for this change.			
Additional	Reliability Data:	ta: Contact your local ON Semiconductor Sales Office or < <u>Phine.Guevarra@onsemi.com</u> >			
Type of no	tification:	This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 90 days prior to implementation of the change. ON Semiconductor will consider this change accepted, unless an inquiry is made in writing within 30 days of delivery of this notice. To do so, contact < <u>PCN.Support@onsemi.com></u>			
Change Pa	rt Identification:	r: Products with date code "U" or greater will have material listed in the table under "(new flow)".			
Change Ca	tegory:	☐ Wafer Fab Change ✔ Assembly Change ✔ Test Change ☐ Other			
Change Sub-Category(s): Manufacturing Site Ad Manufacturing Site Trained Manufacturing Process Sites Affected: Description and Purpose:		nsfer Material Change		 Datasheet/Product Doc change Shipping/Packaging/Marking Other: External Foundry/Subcon Sites: Subcon Thailand 	
Qualify new	assembly and tests Material to be		e the back end capacity. Before change (existing flow)	After 90 day notification (new flow)	
	Assy Sit	e	ON Malaysia	Subcon Thailand	
	Mold Comp		G600FB/G700LS	G600	
	Lead Fran		Ag Plated LF	PPF LF	
	Die Atta	ch	Epoxy CRM1084P	Epoxy QMI519	
	Plating		100% Tin	Pre plated	



Reliability Data Summary:

QV DEVICE NAME:	7WB3125DMR2G
RMS:	S43460, S48165
PACKAGE:	Micro 8

Test	Specification	Condition	Interval	Results
HTOL	JESD22-A108	Ta= 125°C	504hrs	0/240
HTSL	JESD22-A103	Ta= 150°C	1008hrs	0/240
TC	JESD22-A104	Ta= -65°C to + 150°C	500 сус	0/240
HAST	JESD22-A110	130°C, 85% RH, 18.8psig, bias	96 hrs	0/240
uHAST	JESD22-A118	130°C, 85% RH, 18.8psig, unbiased	96 hrs	0/240
	J-STD-020 JESD-			
PC	A113	MSL 1 @ 260°C		0/720
RSH	JESD22- B106	Ta = 265C, 10 sec		0/70
SD	JSTD002	Ta = 245C, 10 sec		0/45

QV DEVICE NAME:	PCA9511ADMR2G
RMS:	S43455, S48165
PACKAGE:	Micro 8

Test	Specification	Condition	Interval	Results
HTOL	JESD22-A108	Ta= 125°C	504hrs	0/231
HTSL	JESD22-A103	Ta= 150°C	1008hrs	0/240
TC	JESD22-A104	Ta= -65°C to + 150°C	500 сус	0/240
HAST	JESD22-A110	130°C, 85% RH, 18.8psig, bias	96 hrs	0/238
uHAST	JESD22-A118	130°C, 85% RH, 18.8psig, unbiased	96 hrs	0/240
PC	J-STD-020 JESD- A113	MSL 1 @ 260°C		0/720
SD	JSTD002	Ta = 245C, 10 sec		0/45
RSH	JESD22- B106	Ta = 265C, 10 sec		0/70

Electrical Characteristic Summary:

Electrical characteristics Available upon request.



List of Affected Parts:		
Part Number	Qualification Vehicle	
7WB3125DMR2G		
7WB3126DMR2G	1	
7WB3305DMR2G		
7WB3306DMR2G		
7WB383DMR2G		
7WBD3125DMR2G	- 7WB3125DMR2G	
7WBD3126DMR2G		
7WBD3305DMR2G		
7WBD3306DMR2G		
7WBD383DMR2G		
PCA9511ADMR2G		
PCA9517ADMR2G	PCA9511ADMR2G	
PCA9517BDMR2G	- FCA32TTADIMIZQ	
PCA9617ADMR2G		